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Application/Control No.	Applicant(s)/Patent under Reexamination
09/830,849	NOMURA ET AL.
Examiner	Art Unit
Adam R. Giesv	2656

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Class	Subclass	Date	Examiner
updated	search	2/2/2006	ARG
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INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
369	112.02	2/2/2006	ARG
369	110.01	2/2/2006	ARG
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
Updated EAST search	2/2/2006	ARG
EAST search included	2/2/2006	ARG
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